Se	arcn	notes	

Application/Control No.	Applicant(s)/Patent u	Applicant(s)/Patent under Reexamination	
10/738,395	OKABE ET AL.		
Examiner	Art Unit		
Marcus Charles	3682		

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SEARCHED			
Class	Subclass	Date	Examiner
474	109-110	9/25/2006	мс
*	101, 161	9/25/2006	mc
75	243-246	9/25/2006	mc
•	230	9/25/2006	mc.
74	462	9/25/2006	me
428	545-548	9/25/2006	me
403	272	9/25/2006	mc
435	69.1	9/25/2006	m
•	69.7	9/25/2006	me
	355, 365	9/25/2006	мс
Search	plotes	2/4/07	me
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ואו	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Data Base	9/25/2006	MC	
\$487 Data Bes	थ्यान	mc	
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